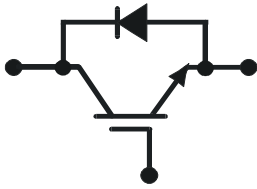


$V_{CE} = 2500 \text{ V}$
 $I_C = 1200 \text{ A}$

ABB HiPak™

IGBT Module
5SNA 1200E250100



Doc. No. 5SYA 1557-02 July 04

- Low-loss, rugged SPT chip-set
- Smooth switching SPT chip-set for good EMC
- Industry standard package
- High power density
- AlSiC base-plate for high power cycling capability
- AlN substrate for low thermal resistance



Maximum rated values ¹⁾

Parameter	Symbol	Conditions	min	max	Unit
Collector-emitter voltage	V_{CES}	$V_{GE} = 0 \text{ V}$		2500	V
DC collector current	I_C	$T_c = 80 \text{ °C}$		1200	A
Peak collector current	I_{CM}	$t_p = 1 \text{ ms}, T_c = 80 \text{ °C}$		2400	A
Gate-emitter voltage	V_{GES}		-20	20	V
Total power dissipation	P_{tot}	$T_c = 25 \text{ °C}$, per switch (IGBT)		11000	W
DC forward current	I_F			1200	A
Peak forward current	I_{FRM}			2400	A
Surge current	I_{FSM}	$V_R = 0 \text{ V}, T_{vj} = 125 \text{ °C}$, $t_p = 10 \text{ ms}$, half-sinewave		11000	A
IGBT short circuit SOA	t_{psc}	$V_{CC} = 1900 \text{ V}, V_{CEMCHIP} \leq 2500 \text{ V}$ $V_{GE} \leq 15 \text{ V}, T_{vj} \leq 125 \text{ °C}$		10	μs
Isolation voltage	V_{isol}	1 min, $f = 50 \text{ Hz}$		5000	V
Junction temperature	T_{vj}			150	$^{\circ}\text{C}$
Junction operating temperature	$T_{vj(op)}$		-40	125	$^{\circ}\text{C}$
Case temperature	T_c		-40	125	$^{\circ}\text{C}$
Storage temperature	T_{stg}		-40	125	$^{\circ}\text{C}$
Mounting torques ²⁾	M_1	Base-heatsink, M6 screws	4	6	Nm
	M_2	Main terminals, M8 screws	8	10	
	M_3	Auxiliary terminals, M4 screws	2	3	

¹⁾ Maximum rated values indicate limits beyond which damage to the device may occur per IEC 60747

²⁾ For detailed mounting instructions refer to ABB Document No. 5SYA2039

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IGBT characteristic values ³⁾

Parameter	Symbol	Conditions	min	typ	max	Unit	
Collector (-emitter) breakdown voltage	$V_{(BR)CES}$	$V_{GE} = 0 \text{ V}$, $I_C = 10 \text{ mA}$, $T_{vj} = 25 \text{ °C}$	2500			V	
Collector-emitter ⁴⁾ saturation voltage	$V_{CE \text{ sat}}$	$I_C = 1200 \text{ A}$, $V_{GE} = 15 \text{ V}$	$T_{vj} = 25 \text{ °C}$	2.2	2.5	2.9	V
			$T_{vj} = 125 \text{ °C}$	2.8	3.1	3.4	V
Collector cut-off current	I_{CES}	$V_{CE} = 2500 \text{ V}$, $V_{GE} = 0 \text{ V}$	$T_{vj} = 25 \text{ °C}$			12	mA
			$T_{vj} = 125 \text{ °C}$		60	120	mA
Gate leakage current	I_{GES}	$V_{CE} = 0 \text{ V}$, $V_{GE} = \pm 20 \text{ V}$, $T_{vj} = 125 \text{ °C}$	-500		500	nA	
Gate-emitter threshold voltage	$V_{GE(TO)}$	$I_C = 240 \text{ mA}$, $V_{CE} = V_{GE}$, $T_{vj} = 25 \text{ °C}$	5		7.5	V	
Gate charge	Q_{ge}	$I_C = 1200 \text{ A}$, $V_{CE} = 1250 \text{ V}$, $V_{GE} = -15 \text{ V} \dots 15 \text{ V}$		12.2		μC	
Input capacitance	C_{ies}	$V_{CE} = 25 \text{ V}$, $V_{GE} = 0 \text{ V}$, $f = 1 \text{ MHz}$, $T_{vj} = 25 \text{ °C}$		186		nF	
Output capacitance	C_{oes}			13.7			
Reverse transfer capacitance	C_{res}			2.98			
Turn-on delay time	$t_{d(on)}$	$V_{CC} = 1250 \text{ V}$, $I_C = 1200 \text{ A}$, $R_G = 1.5 \text{ }\Omega$,	$T_{vj} = 25 \text{ °C}$	375		ns	
			$T_{vj} = 125 \text{ °C}$	365			
Rise time	t_r	$V_{GE} = \pm 15 \text{ V}$, $L_\sigma = 100 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ °C}$	240		ns	
			$T_{vj} = 125 \text{ °C}$	250			
Turn-off delay time	$t_{d(off)}$	$V_{CC} = 1250 \text{ V}$, $I_C = 1200 \text{ A}$, $R_G = 1.5 \text{ }\Omega$,	$T_{vj} = 25 \text{ °C}$	875		ns	
			$T_{vj} = 125 \text{ °C}$	980			
Fall time	t_f	$V_{GE} = \pm 15 \text{ V}$, $L_\sigma = 100 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ °C}$	300		ns	
			$T_{vj} = 125 \text{ °C}$	345			
Turn-on switching energy	E_{on}	$V_{CC} = 1250 \text{ V}$, $I_C = 1200 \text{ A}$, $V_{GE} = \pm 15 \text{ V}$, $R_G = 1.5 \text{ }\Omega$, $L_\sigma = 100 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ °C}$	820		mJ	
			$T_{vj} = 125 \text{ °C}$	1150			
Turn-off switching energy	E_{off}	$V_{CC} = 1250 \text{ V}$, $I_C = 1200 \text{ A}$, $V_{GE} = \pm 15 \text{ V}$, $R_G = 1.5 \text{ }\Omega$, $L_\sigma = 100 \text{ nH}$, inductive load	$T_{vj} = 25 \text{ °C}$	980		mJ	
			$T_{vj} = 125 \text{ °C}$	1250			
Short circuit current	I_{SC}	$t_{psc} \leq 10 \text{ }\mu\text{s}$, $V_{GE} = 15 \text{ V}$, $T_{vj} = 125 \text{ °C}$, $V_{CC} = 1900 \text{ V}$, $V_{CEM \text{ CHIP}} \leq 2500 \text{ V}$		5800		A	
Module stray inductance	$L_{\sigma \text{ CE}}$			10		nH	
Resistance, terminal-chip	$R_{CC'+EE'}$		$T_C = 25 \text{ °C}$	0.06		m Ω	
			$T_C = 125 \text{ °C}$	0.085			

³⁾ Characteristic values according to IEC 60747 – 9⁴⁾ Collector-emitter saturation voltage is given at chip level

Diode characteristic values ⁵⁾

Parameter	Symbol	Conditions	min	typ	max	Unit	
Forward voltage ⁶⁾	V_F	$I_F = 1200 \text{ A}$	$T_{vj} = 25 \text{ °C}$	1.5	1.75	2.0	V
			$T_{vj} = 125 \text{ °C}$	1.4	1.8	2.0	
Reverse recovery current	I_{rr}	$V_{CC} = 1250 \text{ V},$ $I_F = 1200 \text{ A},$ $V_{GE} = \pm 15 \text{ V},$ $R_G = 1.5 \text{ } \Omega$ $L_{\sigma} = 100 \text{ nH}$ inductive load	$T_{vj} = 25 \text{ °C}$		965		A
			$T_{vj} = 125 \text{ °C}$		1180		
Recovered charge	Q_{rr}	$V_{CC} = 1250 \text{ V},$ $I_F = 1200 \text{ A},$ $V_{GE} = \pm 15 \text{ V},$ $R_G = 1.5 \text{ } \Omega$ $L_{\sigma} = 100 \text{ nH}$ inductive load	$T_{vj} = 25 \text{ °C}$		680		μC
			$T_{vj} = 125 \text{ °C}$		1150		
Reverse recovery time	t_{rr}	$V_{CC} = 1250 \text{ V},$ $I_F = 1200 \text{ A},$ $V_{GE} = \pm 15 \text{ V},$ $R_G = 1.5 \text{ } \Omega$ $L_{\sigma} = 100 \text{ nH}$ inductive load	$T_{vj} = 25 \text{ °C}$		1250		ns
			$T_{vj} = 125 \text{ °C}$		1710		
Reverse recovery energy	E_{rec}	$V_{CC} = 1250 \text{ V},$ $I_F = 1200 \text{ A},$ $V_{GE} = \pm 15 \text{ V},$ $R_G = 1.5 \text{ } \Omega$ $L_{\sigma} = 100 \text{ nH}$ inductive load	$T_{vj} = 25 \text{ °C}$		580		mJ
			$T_{vj} = 125 \text{ °C}$		960		

⁵⁾ Characteristic values according to IEC 60747 – 2

⁶⁾ Forward voltage is given at chip level

Thermal properties

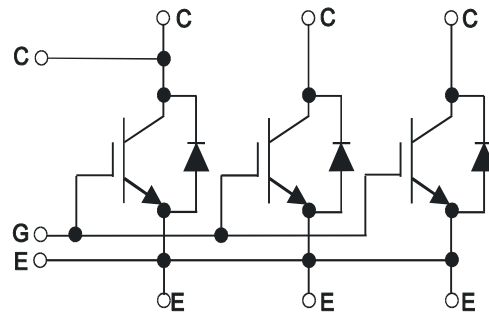
Parameter	Symbol	Conditions	min	typ	max	Unit
IGBT thermal resistance junction to case	$R_{th(j-c)IGBT}$				0.009	K/W
Diode thermal resistance junction to case	$R_{th(j-c)DIODE}$				0.017	K/W
Thermal resistance case ²⁾ to heatsink	$R_{th(c-h)}$	per module, λ grease = $1\text{W/m} \times \text{K}$		0.006		K/W

²⁾ For detailed mounting instructions refer to ABB Document No. 5SYA2039

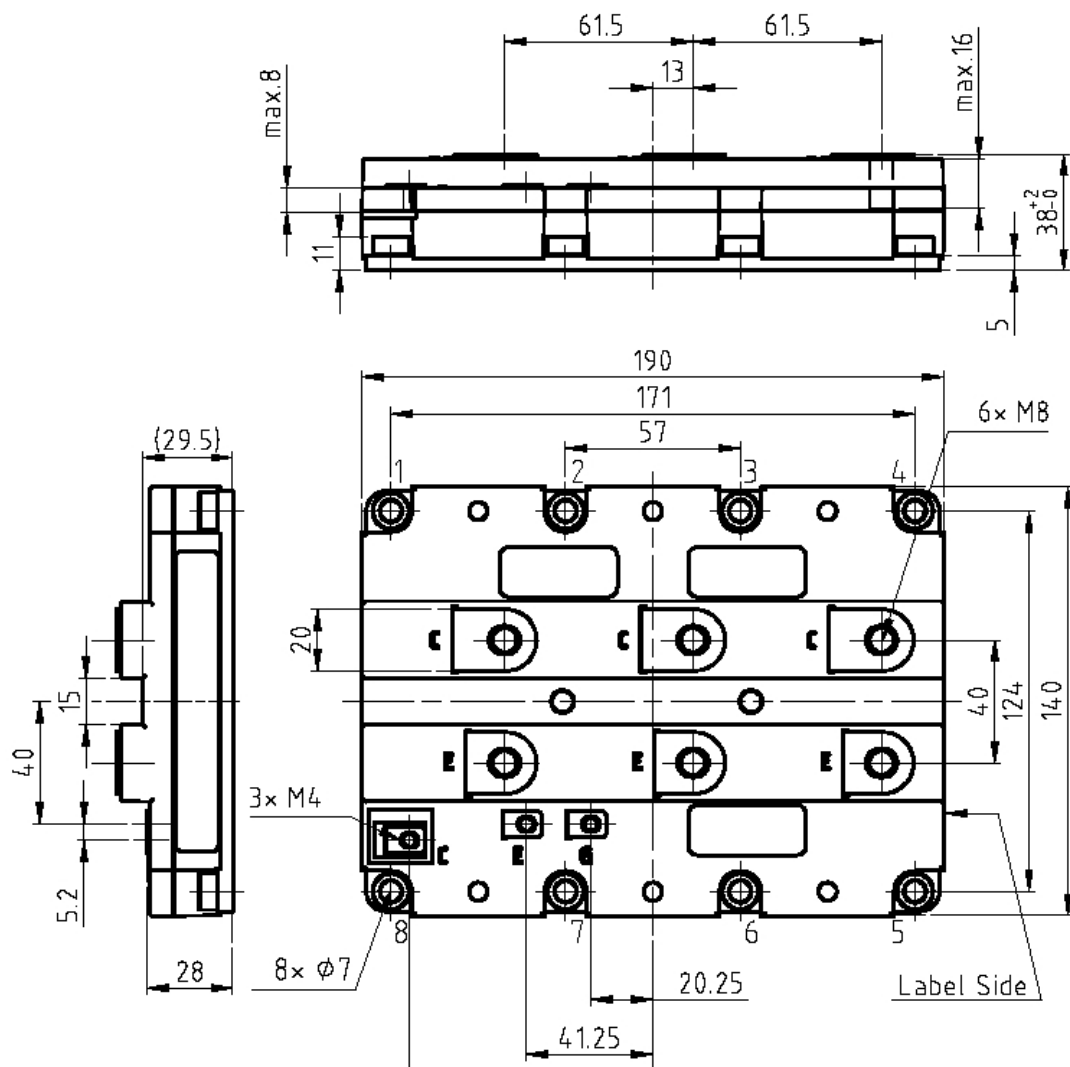
Mechanical properties

Parameter	Symbol	Conditions	min	typ	max	Unit
Dimensions	$L \times W \times H$	Typical , see outline drawing	190 × 140 × 38			mm
Clearance distance	D_C	according to IEC 60664-1 and EN 50124-1	Term. to base:	23		mm
			Term. to term:	19		
Surface creepage distance	D_{SC}	according to IEC 60664-1 and EN 50124-1	Term. to base:	33		mm
			Term. to term:	32		
Weight				1500		g

Electrical configuration



Outline drawing ²⁾



Note: all dimensions are shown in mm

²⁾ For detailed mounting instructions refer to ABB Document No. 5SYA2039

This is an electrostatic sensitive device, please observe the international standard IEC 60747-1, chap. IX.

This product has been designed and qualified for Industrial Level.

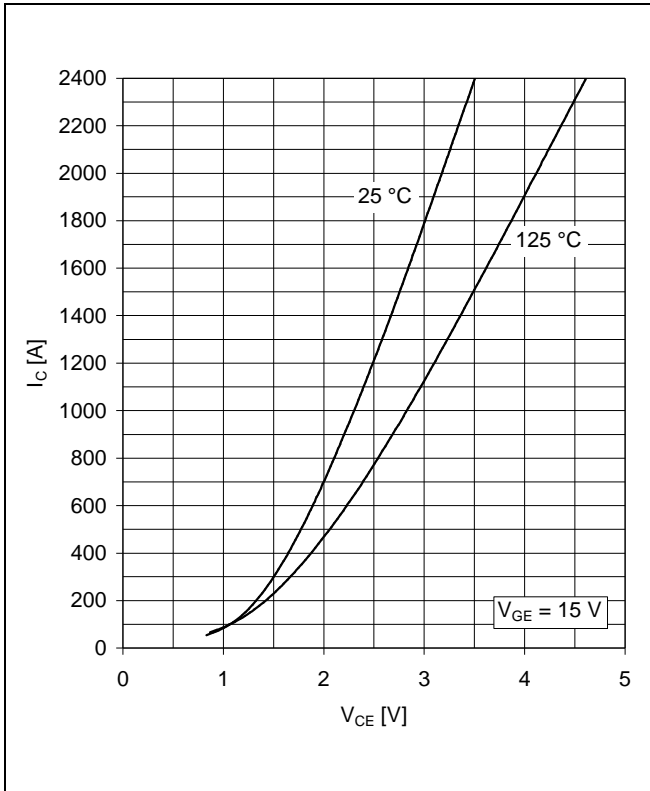


Fig. 1 Typical on-state characteristics, chip level

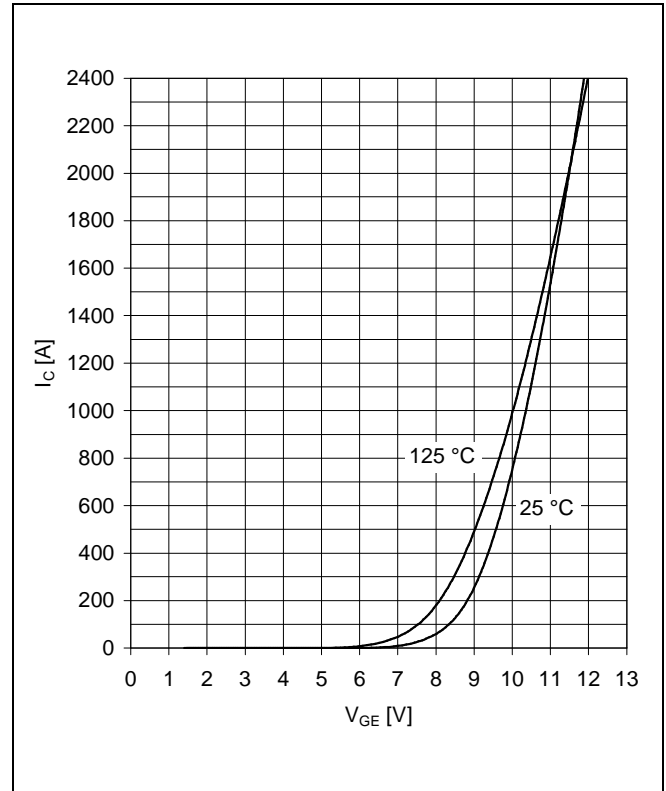


Fig. 2 Typical transfer characteristics, chip level

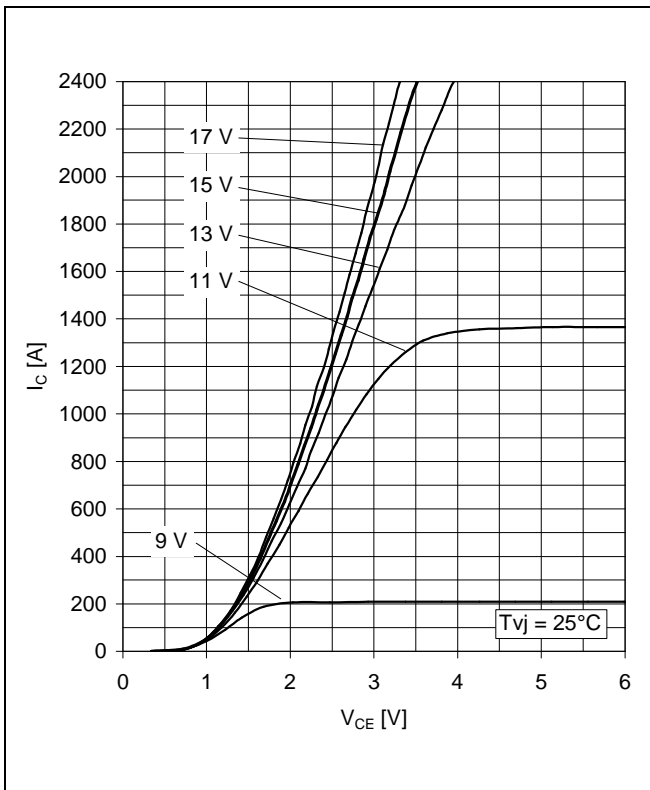


Fig. 3 Typical output characteristics, chip level

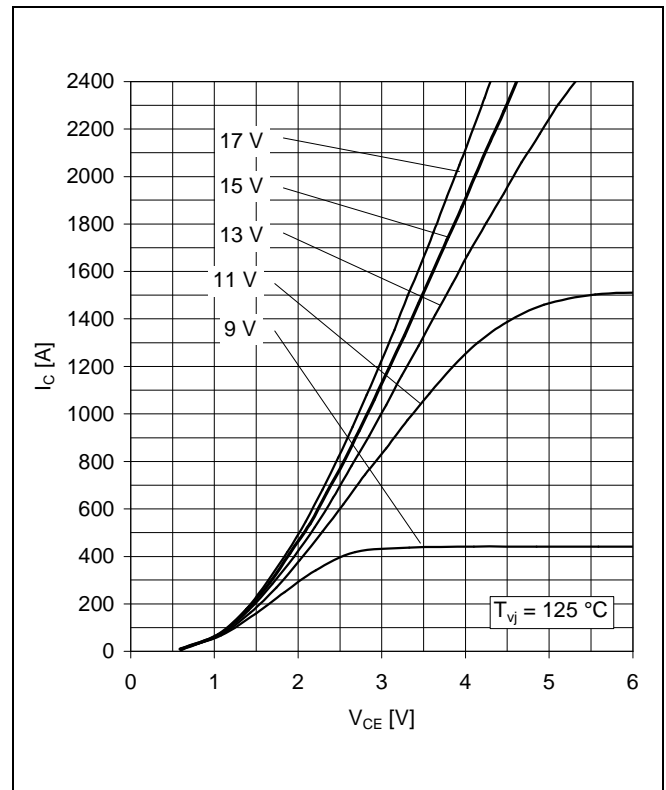


Fig. 4 Typical output characteristics, chip level

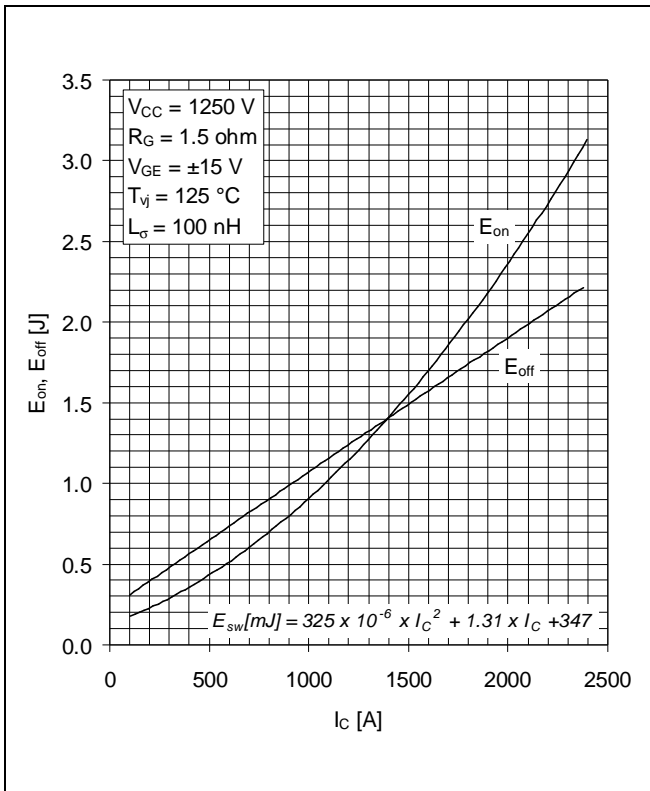


Fig. 5 Typical switching energies per pulse vs collector current

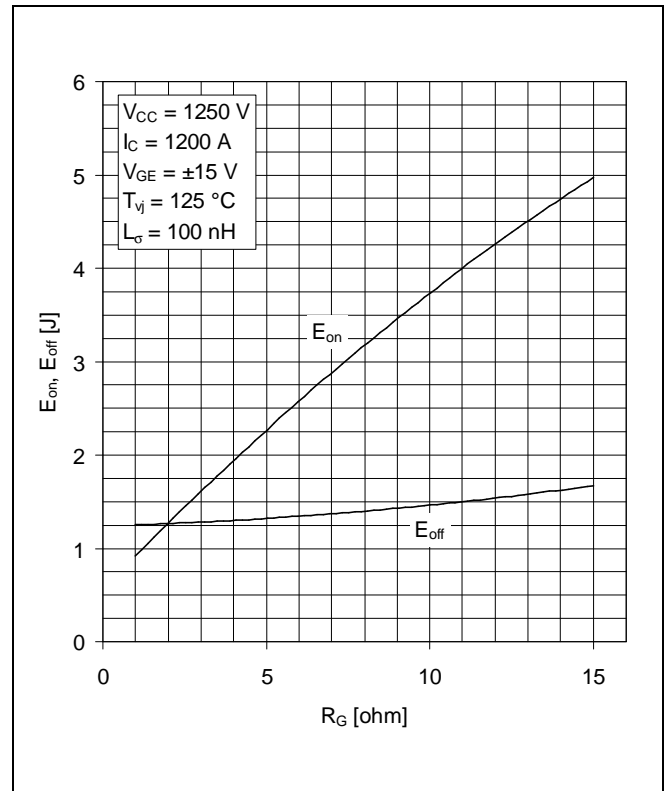


Fig. 6 Typical switching energies per pulse vs gate resistor

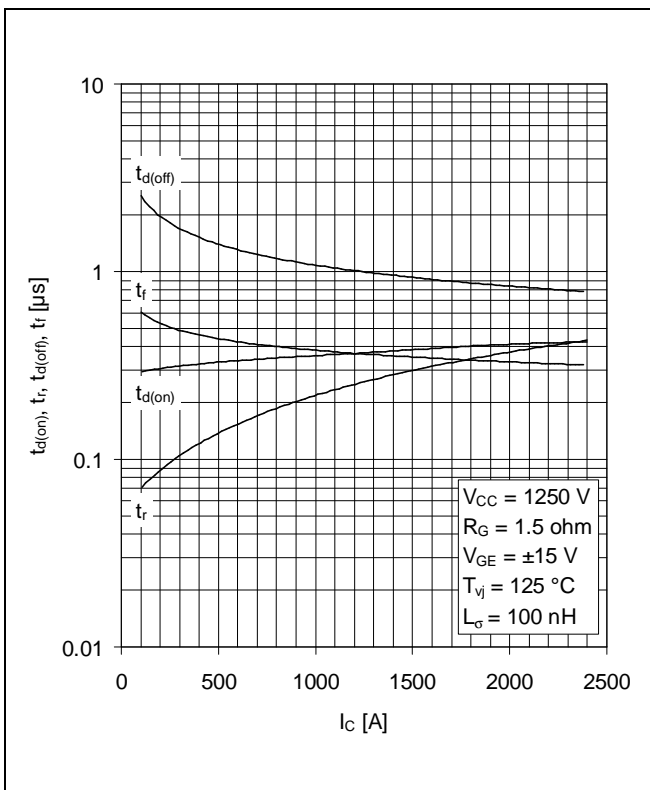


Fig. 7 Typical switching times vs collector current

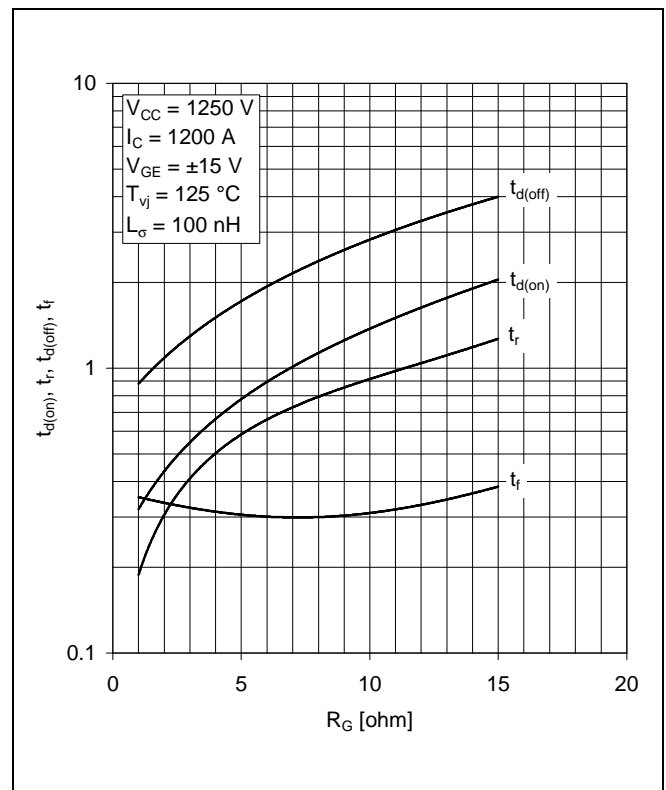


Fig. 8 Typical switching times vs gate resistor

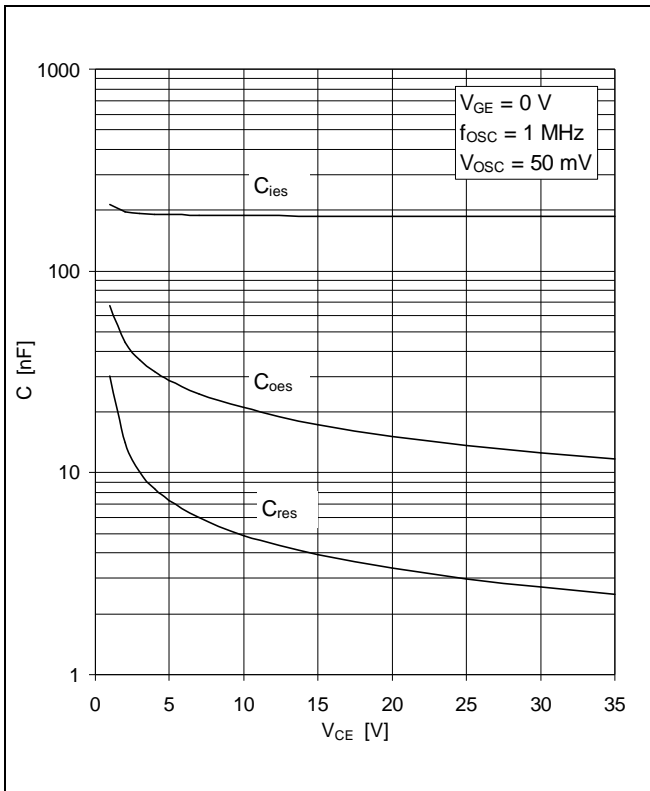


Fig. 9 Typical capacitances vs collector-emitter voltage

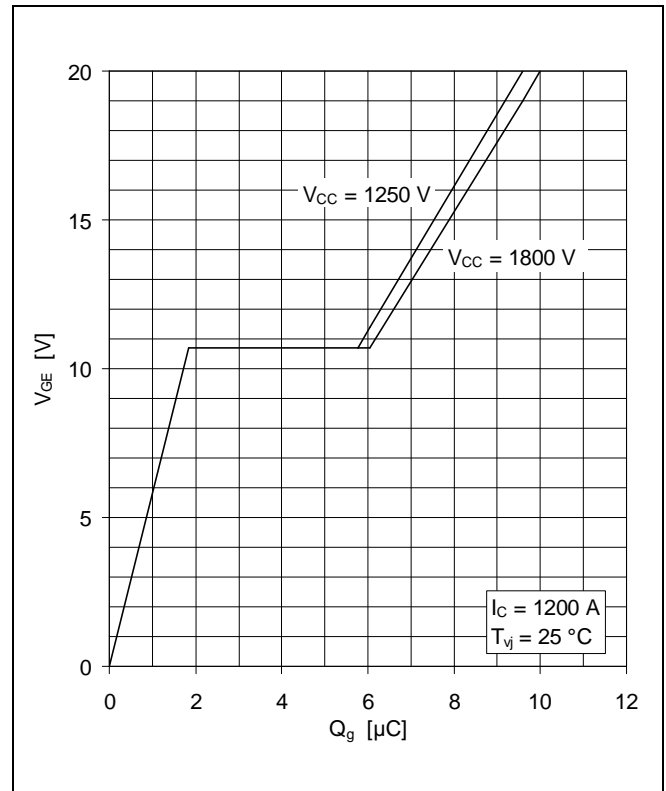


Fig. 10 Typical gate charge characteristics

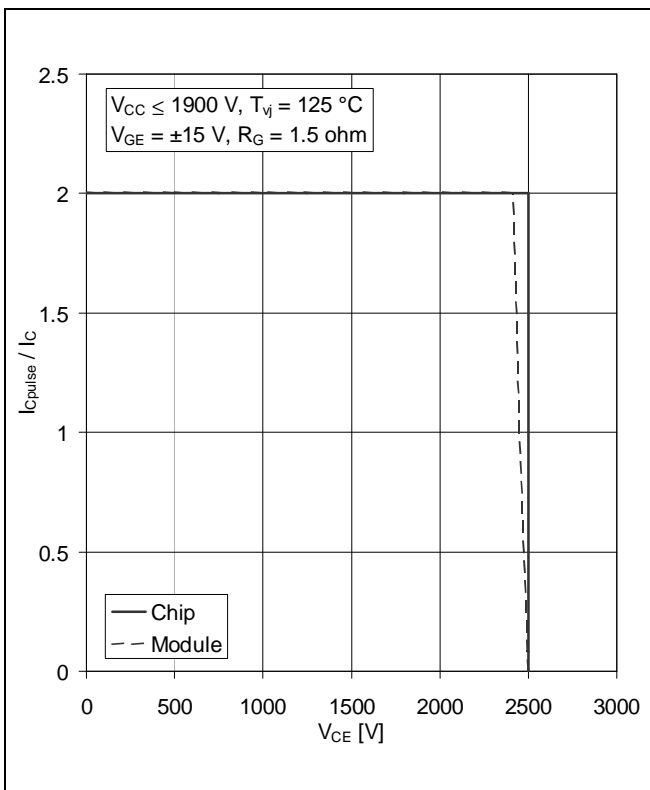


Fig. 11 Turn-off safe operating area (RBSOA)

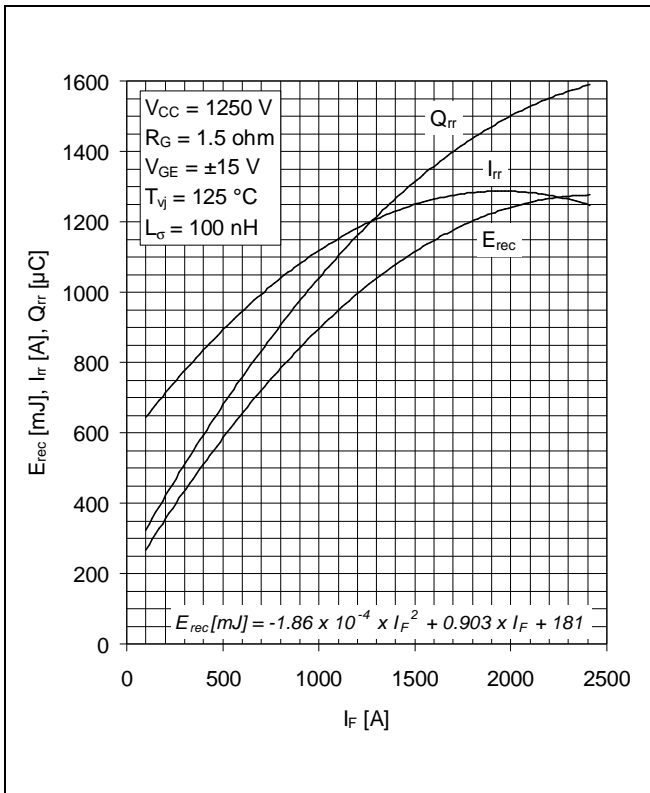


Fig. 12 Typical reverse recovery characteristics vs forward current

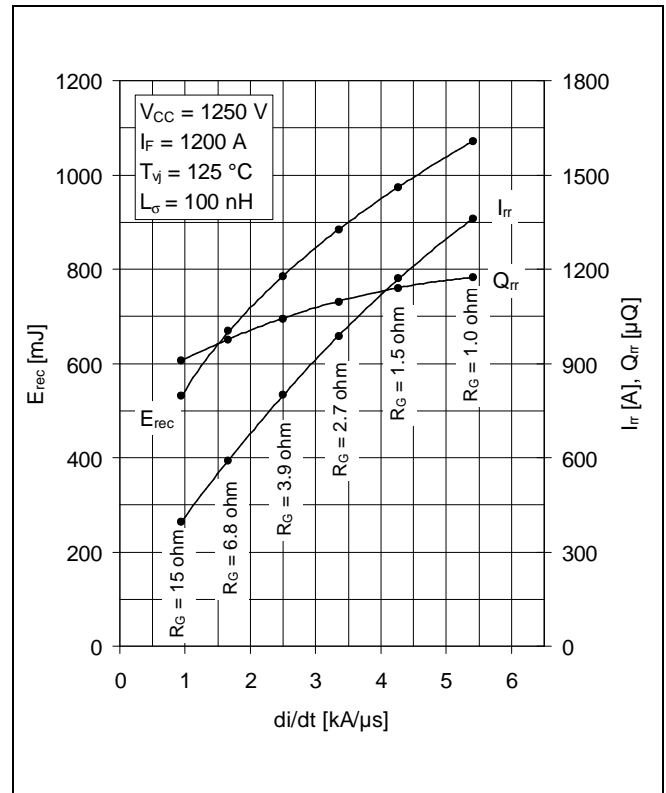


Fig. 13 Typical reverse recovery characteristics vs di/dt

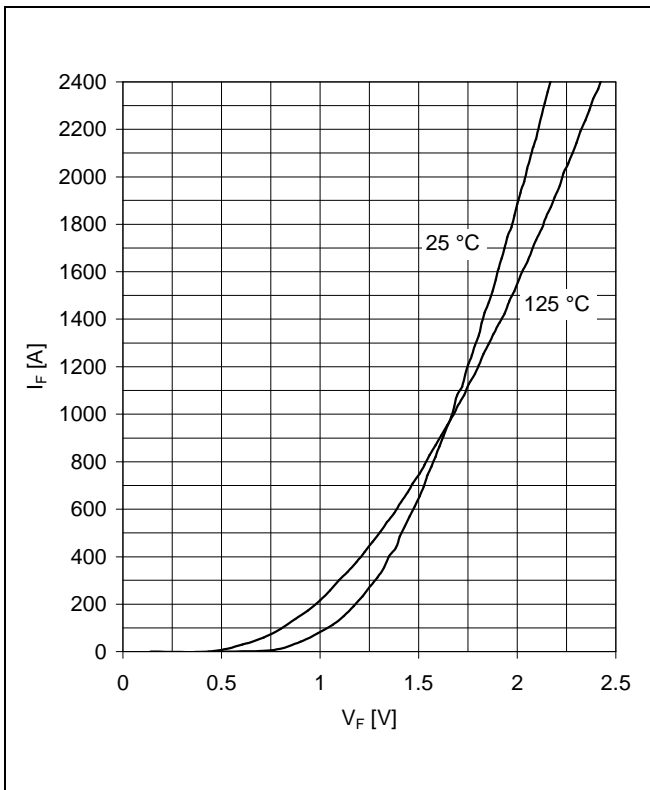


Fig. 14 Typical diode forward characteristics, chip level

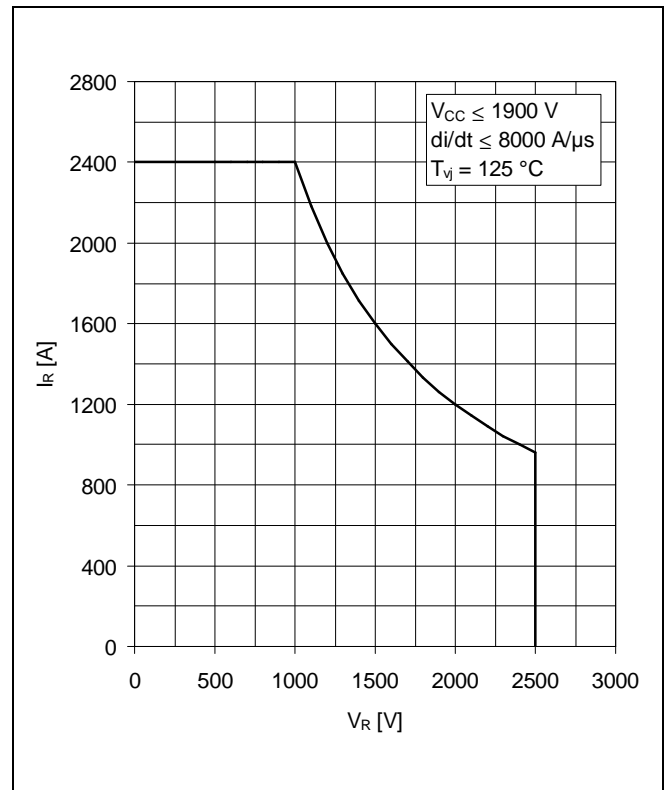


Fig. 15 Safe operating area diode (SOA)

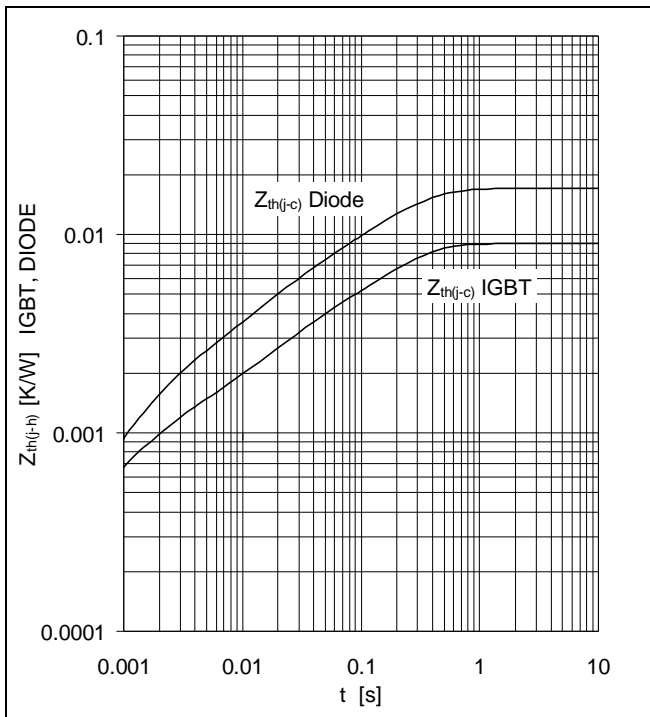


Fig. 16 Thermal impedance vs time

Analytical function for transient thermal impedance:

$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i (1 - e^{-t/\tau_i})$$

	i	1	2	3	4	5
IGBT	$R_i(K/kW)$	6.287	1.685	0.685	0.337	
	$\tau_i(ms)$	194.7	20.4	1.98	0.52	
DIODE	$R_i(K/kW)$	11.54	2.92	1.28	1.27	
	$\tau_i(ms)$	203.4	29.3	6.96	1.5	

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